8-CH CAPACITIVE TOUCH SENSOR SPECIFICATIONS

1. REVISION HISTORY

| Rev | CONTETNS | DATE |
|-----|----------------|----------------------------|
| 1.0 | First Creation | May 3th, 2008 |
| 2.0 | Major Updated | Jun 1 th , 2008 |
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2. FEATURES

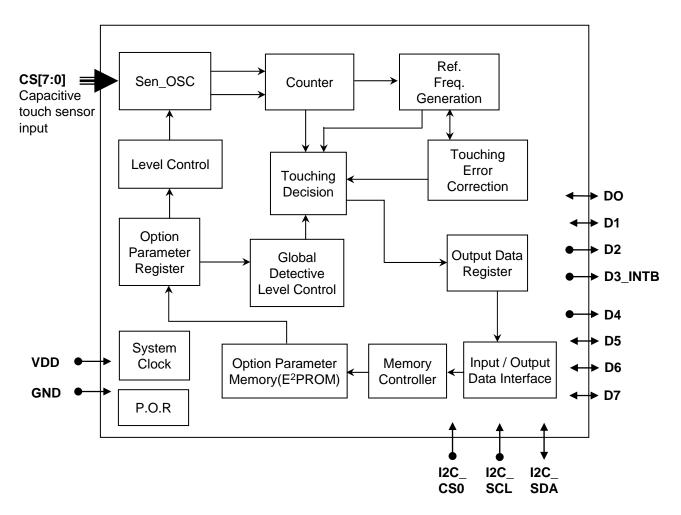
2.1 General Feature

- 8-ch capacitive sensor with auto sensitivity calibration
- Package type: MLF2-24[4*4], ML2-32[5*5], SOP28[300mil]
- I2C serial interface
- Auto-Sleep mode(Burst and Sleep mode)
- Global/Local channel adjustable sensitivity
- Touchoutput Mode for parallel operation
- Touch intensity can be detectable
- Adjustable internal frequency by REXT resistor
- 8ch Open-drain digital output
- Embbeded high frequency noise elimination circuit

2.2 Application

- Moble application(mobile phone / PDA / MP3 player etc)
- Membrane switch replacement
- Sealed control panels, keypads
- Door key-lock matrix application
- Touch screen replacement application

3. BLOCK DIAGRAM



- Common Pin: VDD, GND

- Serial Interface Pin: I2C_SCL, I2C_SDA

- I2C Slave Address : B8h[10111000₂], 54h[01010100₂]

- Reset : Internal POR[VDD Active Voltage : 1.5V]

4. ELECTRICAL CHARACTERISTICS

4.1 Absolute Maximum Ratings

| Symbol | ITEM | Value | Unit |
|--------------------|-----------------------------|--------------------------|------------|
| V _{DD} | Supply Voltage | 3.0 ~ 5.5 | |
| V _{IN} | Input Voltage Range | $-0.3 \sim V_{DD} + 0.3$ | |
| V _{OUT} | Output Voltage Range | $-0.3 \sim V_{DD} + 0.3$ | V |
| V_{PPH} | External VPP for EEPROM | $V_{PPL} + 3.5$ | |
| V _{PPL} | External VPP for EEPROM | 12.8 ~ 13.6 | |
| Imax | Maximum Current | 300uA @ Vdd = 3.3V | A |
| Pmax | Maximum Power Dissipation | 800mW | W |
| ESD Stress V | ESD protection | H.B.M 8000 | V |
| T _{OPR} | Operating Temperature Range | -40 ~ +85 | °C |
| T_{STG} | Storage temperature Range | −50 ~ +125 | $^{\circ}$ |

4.2. DC Characteristics

$$(V_{DD} = 3.3V, Ta = -40 \sim 85 ^{\circ}C)$$

| Symbol | ITEM | Conditions | Related Pins | MIN | TYP | MAX | UNIT |
|-----------------|-----------------------------|---|-------------------|---------------------|------------|--------------|------|
| V_{DD} | Operating Voltage | - | V_{DD} | 3.0 | - | 5.5 | V |
| V _{IH} | High Logic Input Level | Iout = 100 <i>μ</i> A | Logical Input | 0.7*V _{DD} | - | V_{DD} | |
| $V_{_{\rm IL}}$ | Low Logic Input Level | Iout = 100 <i>μ</i> A | Logical Input | 0 | - | $0.3*V_{DD}$ | v |
| V_{OH} | High Logic Output Level | $Iout = 10\mu A$ | Logical Output | 0.9*V _{DD} | ı | V_{DD} | v |
| V_{OL} | Low Logic Output Level | Iout = 100 <i>μ</i> A | Logical Output | 0 | ı | $0.1*V_{DD}$ | |
| I_{IL} | Input Leakage Current | | | -1.0 | - | +1.0 | uA |
| $I_{ m DD}$ | Current consumption | VDD=3.3V, BF mode VDD=3.3V, Sleep mode | | | 240 100 | 300 150 | uA |
| I_{SNK} | Output maximum sink current | $V_{DD} = 3.3V$, Rbias=500K | | - | - | 4.0 | mA |
| C _{IN} | Input capacitance range | | | - | 4 | - | pF |
| ΔC | Minmum detective cap. diff. | $C_S = 4pF$ | | - | 0.1 | - | pF |
| | | | | | | | |

5. PIN DESCRIPTION

5. 1. Power Supply Pins

| Signal | Quantity | ТҮРЕ | Function |
|--------|----------|-------|---|
| VDD | 1 | POWER | DV _{DD} /AV _{DD} [Double Bonding] |
| GND | 1 | GND | DGND/AGND [Double Bonding] |

5.2. System Control Pins

| Signal | Quantity | TYPE | Function |
|----------|----------|------|---|
| SYNC_INT | 1 | I/O | - Multi-Chip Mode Control Pin - Normal Operation : INTERRUP Out for touch output status - LDO Power Control |

5.3. MPU Interface Pins

| Signal | Quantity | ТҮРЕ | Function |
|---------|----------|------|---|
| I2C_CS0 | 1 | I | I ² C Chip Select Pin, Default : Low |
| I2C_SCL | 1 | I | I ² C Clock Input Pin |
| I2C_SDA | 1 | I/O | I ² C Data In/Output Pin |

5.4. Sensor Input Pins

| Signal | Quantity | ТҮРЕ | Function |
|----------|----------|------|---------------------|
| CS [7:0] | 8 | I/O | Analog sensor input |

5.5. Parallel Output Pins

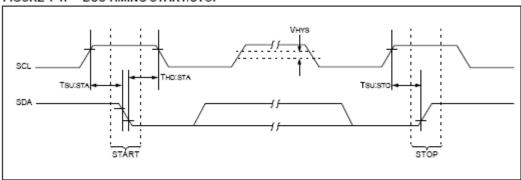
| Signal | Quantity | ТҮРЕ | Function |
|--------|----------|------|--|
| D[7:0] | 8 | I/O | - Digital Touch Output Pins[Open Drain I/O Port] - D3_INTB: INTERRUP Out for touch output status - D7: IR Input Port |

6. FUNCTIONAL DESCRIPTION

6.1 MPU Interface

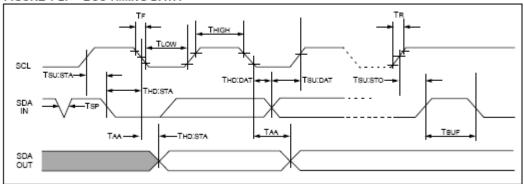
6.1.1 I²C (Inter-Integrated Chip) – Bus Timing Start/Stop

FIGURE 1-1: BUS TIMING START/STOP

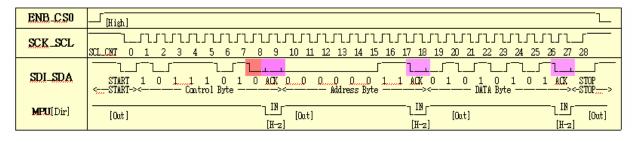


6.1.2 I²C (Inter-Integrated Chip) – Bus Timing Data

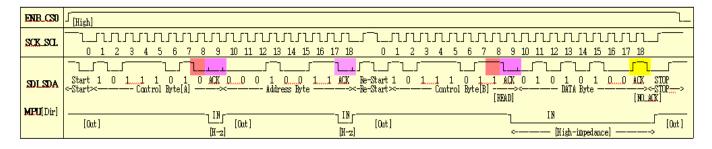
FIGURE 1-2: BUS TIMING DATA



6.1.3 I²C Write Function

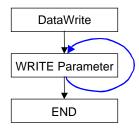


6.1.4 I²C Read Function

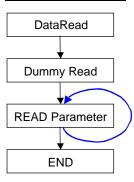


6.2 Parameter Data Write / Read Sequence

Parameter Data Write



Parameter Data Read



6.3 Sensor Output Data Read Sequence

Touch output data (8bits) are sent to output register. To complete the touch data output, these two registers must be read out sequentially.

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|
| ch7 | ch6 | ch5 | ch4 | ch3 | ch2 | ch1 | ch0 |

← output register

6.4 Output hold time

If it keeps touch-on state, the output holds "1" or touch-on till 10 sec. At 10 sec it resets and do self-calibration.

| Output hold time (Thold) ~ 10 sec | | @ 10 sec | |
|-----------------------------------|-----------|---------------------|--|
| Input Touch Keeps touch-on | | Keeps touch-on | |
| Output | Holds "1" | Do self-calibration | |

6.5 Self Calibration

1 After the system resets, it does self-calibration.

It calibrates base line and threshold automatically for each touch channel.

| action | time | Etc. |
|------------------------------|--------|------|
| Self-calibration time (TCAL) | 3.9 ms | |

6.6 Touch Decision

6.6.1 Basic Touch Decision

1 To decide it is touched or not, reference and threshold are needed.

If the sensor signal goes below the threshold and stays for required duration time, the touch output goes "1" which means "touched"

Sensor signal:

It is the output of the counter of sensor oscillator. It varies with real time touch sensor capacitance.

Reference signal:

It is the average of the previous N scan counts for each channel. While touch output is "1"(touched), it is not updated. And the status goes to non-touch, it updates.

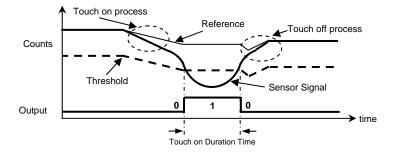
Threshold signal:

Threshold is for protection against weak noise. It is subtracted by constant number from reference.

The value is parameterized.

I Touch on duration:

Touch on duration time is also for short time noise protection. It is parameterized.



6.7 Detection Level Control

6.7.1 Description

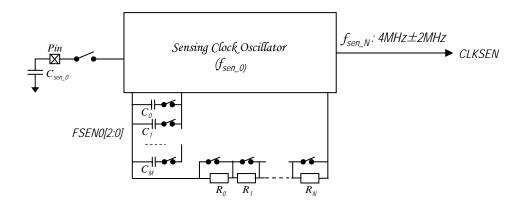
It has 3 ways of controlling the touch detection level (local oscillator control, local touch threshold, global touch threshold).

6.7.2 Local Detection Level Control at Oscillator

1 To adjust the oscillator frequency the *C* and *R* values are selectable using option parameters.

I When a touch channel is selected by mux, the register values for this channel are set to oscillator.

The number of possible oscillator combinations is FSEN0 ~ FSEN7.



6.7.3 Local Detection Level Control by Touch Threshold of Each Channel.

I We can set local threshold factor for each channel.

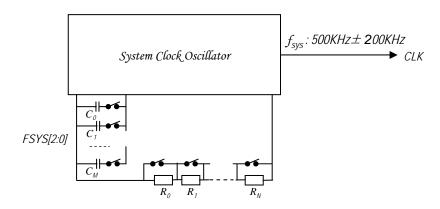
6.7.4 Global Detection Level Control by Global Touch Threshold

I We can set global threshold.

6.8 Frequency Adjustment for System Clock

 ${
m I\hspace{-.1em}I}$ To adjust the system clock frequency the C and R values are selectable using option parameters.

The number of possible oscillator combinations is FSYS[2:0].



6.9 Concurrent Touch Handling

It has concurrent touch handling function which can distinguishes the intended key(s) from concurrently touched keys. There are the following four cases, first touched, last touched, both and deeply touched, according to the option parameter. Please refer 0Ah.

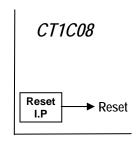
6.10 Power Save

| Function | Sleep | Soft Reset | |
|----------|------------------|-------------------------------|--|
| Command | SLEEPON/OFF | SOFTRES | |
| Function | - OSC Start/Stop | - Register Clear - SLEEPON | |

6. 11 Reset

We use the internal reset circuit, which reset the entire chip when the power (VDD) is on [POR], It reset the chip when VDD go over 1,5V automatically.

When SOFTRES command is inputted, All Registers are set Default



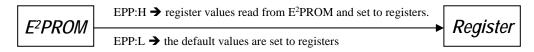
[Internal Reset Mode]

6. 12 E²PROM

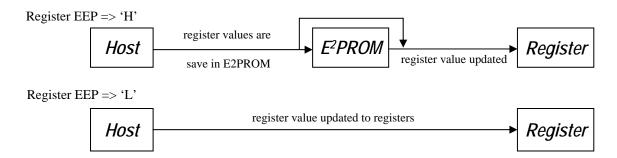
In power-on mode, when the Register EEP Mode is 'H', the register values in E^2 PROM are got and set to registers. But when the Register EEP Mode is 'L', the default register values are set to the registers.

In programming mode you can use E^2PROM as the register memory or not. When Register EEP Mode is 'H', E^2PROM is used. The register values from host are saved in E^2PROM and at the same time set to registers. When EEP is 'L', the register values from host are set to registers directly.

6. 12. 1 Power-up mode



6. 12. 2 Programming mode



6.12.3 Description

 \blacksquare Register EEP Mode selects the use of E²PROM(EEP:H) or the non-use of E²PROM(EEP:L) for option parameter saving. If EEP is set to "H", the command saves the option parameter in E²PROM and updates the related register. When RSTB goes to "H", it reads the E²PROM data and sets them to related registers. But if EEP is set to "L", the command just updates the related register. When RSTB goes to "H", the registers have the default parameters.

| | Register EEP | Comments |
|-----------------------------|--------------|--|
| Use E ² PROM | Н | to use the internal E ² PROM for option parameter saving. |
| Non-use E ² PROM | L | not to use the internal E ² PROM for option parameter saving. |

6.12.4 E²PROM Read Mode

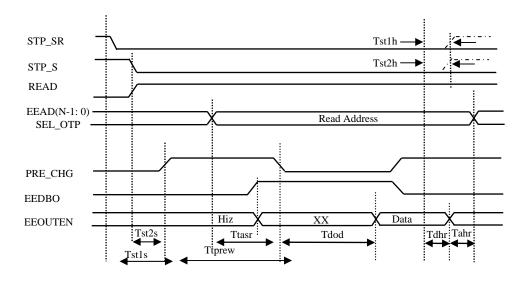


Figure 4-1. Read mode iming

Table4-4 READ Mode

| Parameter | Symbol | Conditions | Min | Тур | Max | Uint |
|--------------------|--------|------------|-----|-----|-----|------|
| CTD setup time | Tst1s | | 100 | - | | ms |
| STP setup time | Tst2s | | 0 | - | | ms |
| STP hold time | Tst1h | | 10 | | | ms |
| STP floid tillie | Tst2h | | 10 | | | ms |
| Address hold time | Tahr | | 0 | | | ms |
| Data hold time | Tdhr | | 0 | | | ms |
| Duo obougo | Tomarr | VDD≥2.7V | 75 | | | ms |
| Pre-charge | Tprew | VDD≥4.5V | 45 | | | ms |
| Address setup time | Tasr | VDD≥2.7V | 75 | | | ms |
| Address setup time | Tasr | VDD≥4.5V | 45 | | | ms |
| Data output dalari | Tdod | VDD≥2.7V | 70 | | | ms |
| Data output delay | Tuou | VDD≥4.5V | 40 | | | ms |

- . When SEL_ OPT=H and EEAD(N_1: 3)=00H, OTP Area is selected
- . When EEOUTEN=L, EEDBO(7: 0)=Hiz, When data is to output, EEOUTEN should be set to H.
- . When STP_SR=L and STP_S=L, data can be read out continuously

6.12.5 E²PROM Programming Mode

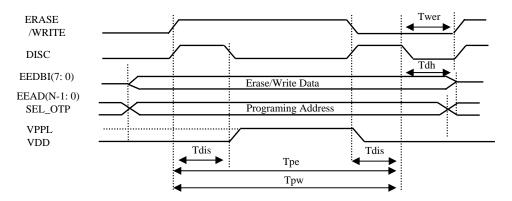


Figure 4-2 Programming mode

| Parameter | Symbol | Conditions | Min | Тур | Max | Uint |
|------------------------|--------|------------|-----|-----|-----|------|
| Erase Pulse Width | Tpe | | 1.4 | - | 3.6 | ms |
| WriTe Pulse Width | Tpw | | 1.4 | - | 3.6 | ms |
| WriTe/Erase reset Time | Twer | | 500 | - | | ms |
| Address setup Time | Taddrs | | 0 | - | | ms |
| Address hole Time | Taddrh | | 0 | - | | ms |
| Data setup Time | Tds | | 0 | - | | ms |
| Data hole Time | Tdh | | 0 | - | | ms |
| Discharge width | Tdis | | 3 | | | ms |

6.12.6 E²PROM Test Mode (ION Check)

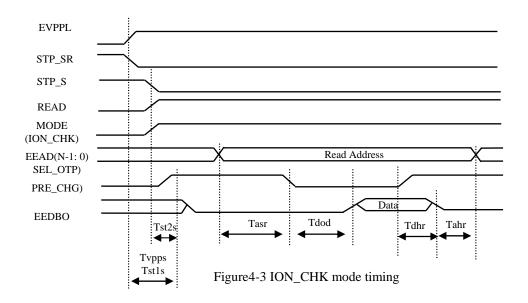


Table4-6 Test mode→ION_CHK

| Parameter | Symbol | Conditions | Min | Тур | Max | Uint |
|-----------------------|--------|------------|-----|-----|-----|------|
| CTD cotum Time | Tst1s | | 100 | | | ms |
| STP setup Time | Tst2s | | 0 | | | ms |
| Address setup Time | Tahr | | 0 | | | ms |
| Address hole Time | Tasr | VDD≥2.7V | 75 | | | ms |
| Address note Time | Tasr | VDD≥4.5V | 45 | | | ms |
| Data autmut dalari | Tdod | VDD≥2.7V | 1 | | | ms |
| Data output delay | 1 dod | VDD≥4.5V | 1 | | | ms |
| Data output hold Time | Tdhr | | 0 | | | ms |
| EVPP setup Ttime | Tvpps | | 100 | | | ms |

[.] When SEL _OPL=H and EEAD(N-1:3)=00H, OTP Area is selected.

6.12.7 E²PROM Test Mode (CP Test)

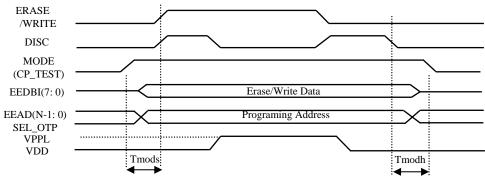


Figure4-4 CP_TEST mode timing

Table4-7 Test mode→CP_TEST

| Parameter | Symbol | Conditions | Min | Тур | Max | Uint |
|--------------------|--------|------------|-----|-----|-----|------|
| CP TEST setup Time | Tmods | | 0 | | | ms |
| CP TEST hold Time | Tmodh | | 0 | | | ms |

[.] Please refer to Table 4-5 for the parameters not included in Table 4-7

6.12.8 E²PROM Test Mode (EXT_VPP)

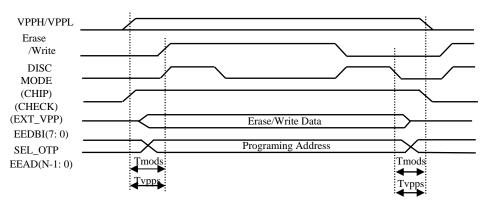


Figure4-5 EXT_VPP (CHIP/CHECKER) mode timing

Table4-8 Test mode→EXT_VPP

| Parameter | Symbol | Conditions | Min | Тур | Max | Uint |
|---------------------|--------|------------|-----|-----|-----|------|
| VPP setup time | tvpps | | 0 | | | ms |
| VPP hold time | tvpph | | 0 | | | ms |
| EXT_ VPP hold time | texh | | 0 | | | ms |
| EXT_ VPP setup time | texs | | 0 | | | ms |
| MODE setup time | tmods | | 0 | | · | ms |
| MODE hold time | tmodh | | 0 | | | ms |

[.] Please refer to Table 4-5 for the parameters not included in Table 4-7

[.] Internal VPP mode is also allowed in chip mode and checker mode.

7. COMMAND LIST

7.1 System Control Mode

| INSTRUCTION | Command | | | | Para | metei | : | | | Parameter Definition | Default | | | | | | | | | | |
|-------------|---------|----|----|----|------|-------|----|----|----|---|---------|---|---|----|---|---|---|---|---|---|---|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Tarameter Definition | Default | | | | | | | | | | |
| | | - | - | - | - | - | - | - | D0 | EEPROM Reset Update Mode [EEP Pin] D0 : 0 -> Disable D0 : 1 -> Enable | 1 | | | | | | | | | | |
| | | - | - | - | - | - | - | D1 | - | EEPROM Data Write Mode D1 : 0 -> Disable D1 : 1 -> Enable | 1 | | | | | | | | | | |
| EEPSET | 00h | - | - | - | 1 | - | D2 | - | - | EEPROM Erase/Write Delay Time Setting Mode D2:0->2ms D2:1->3ms | 0 | | | | | | | | | | |
| | | · | - | - | ı | D3 | - | - | · | D3 : Null | 0 | | | | | | | | | | |
| | | - | - | - | D4 | - | - | - | - | D4 : 0 -> I2C_SDA PIN Pull Up D4 : 1 -> I2C_SDA PIN Open-drain | 0 | | | | | | | | | | |
| | | | | | | | | | | | | - | - | D5 | - | - | - | - | - | D5 : 1 -> SYNC_INT PIN Pull Up D5 : 0 -> SYNC_INT PIN Open-drain | 0 |

7.2 Soft Reset

| INSTRUCTION | Command | | | | Para | meter | ſ | | | Parameter Definition | Default | |
|-------------|-------------|--------|----|----|------|-------|----|----|----|----------------------|----------------------|--------|
| | INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Parameter Definition | Detaun |
| | SOFTRES | 01h | х | x | х | х | x | х | х | х | Software Reset | - |

Software reset command

7.3 Parallel Interface Selection

| INSTRUCTION | Command | | | | Parai | neter | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|-------|-------|----|----|----|--|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Faranietei Demitton | Detaun |
| | | - | - | - | - | - | - | - | D0 | Parallel interface Output D0:0 -> Disable [Test Signal & Interrupt Output] D0:1 -> Enable | 1 |
| | | - | - | - | - | - | - | D1 | - | Parallel Output Polarity D1:0 -> Default Direct [TOUCH -> Low] D1:1 -> Reverse Direct [TOUCH -> High] | 0 |
| ICPSEL | 02h | - | - | - | - | - | D2 | - | - | Interrupt Output Mode [INTB] D2: 0 -> Touch On Mode [Low Active] D2: 1 -> Touch On/Off Edge Mode [Low Active : 6us] | 0 |
| | | - | - | - | - | D3 | - | - | - | Interrupt Output Pin Select [INTB] -> Only Single Chip Mode D3: 0 -> INTB Out Pin [D3_INTB] D3: 1 -> INTB Out Pin [SYNC_INT] | 0 |
| | | - | - | - | D4 | - | - | - | - | LED Output Mode -> LED Data Bit Register : LEDCTRL[07h] D4 : 0 -> LED Output Mode Disable D4 : 1 -> LED Output Mode Enable | 0 |

 $\mathbb{I}\,$ Interrupt Mode & Test Output Mode : D0 -> 0

7.4 Touch Key Enable

| INSTRUCTION | Command | | | | Para | meter | r | | | Parameter Definition | D-f14 |
|-------------|---------|----|----|----|------|-------|----|----|----|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Parameter Definition | Default |
| | | | | | | | | | | D0: 0 -> disabled, 1 -> enabled for 1st channel | 1 |
| | | | | | | | | | | D1: 0 -> disabled, 1 -> enabled for 2 nd channel | 1 |
| KEYENABLE0 | 03h | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | | 1 |
| | | | | | | | | | | D6: 0 -> disabled, 1 -> enabled for 6 th channel | 1 |
| | | | | | | | | | | D7: 0-> disabled, 1-> enabled for 7 th channel | 1 |

¹ Each key can be specified to use or not to use(or enabled / disabled)

Disabled key has the same time sharing to enabled key, almost no activity with disabled key.

7.5 Noise Key Setting

| INSTRUCTION | Command | | | | Para | metei | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|------|-------|----|----|----|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Parameter Definition | Deraun |
| | | | | | | | | | | D0: 0 -> disabled, 1 -> enabled for 1st channel | 0 |
| | | | | | | | | | | D1: 0-> disabled, 1-> enabled for 2 nd channel | 0 |
| NOISEKEY | 04h | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | | 0 |
| | | | | | | | | | | D6: 0 -> disabled, 1 -> enabled for 6 th channel | 0 |
| | | | | | | | | | | D7: 0-> disabled, 1-> enabled for 7th channel | 0 |

7.6 Sleep Mode Selection

| INSTRUCTION | Command | | | | Para | meter | r | | | Parameter Definition | Default |
|-------------|---------|----|----|----------|------|-------|----|----|----|--|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Farameter Deminion | Detaun |
| | | 1 | - | - | - | - | - | - | D0 | D0: 0 -> Stay in Burst Mode | 0 |
| SLEEPSEL | | | | <u> </u> | | | | | | D0: 1 -> go to sleep mode 500ms after touched or power-up automatically. | |
| | | | | ١. | ١. | ١. | ١. | D1 | ١. | D1:0-> Sleep Mode Delay Time Select: 1s. | 0 |
| | 05h | | | | | | | Di | | D1:1-> Sleep Mode Delay Time Select:2s. | Ü |
| NSCANBF | 0311 | | | | D4 | | | | | D4: 0 -> 100 Hz [10.0ms/8ch, 1.250ms/1ch] | 0 |
| NSCANBF | | - | - | - | D4 | - | - | - | - | D4: 1 -> 60 Hz [16.6ms/8ch, 2.083ms/1ch] | U |
| NSCANSLP | | | | D5 | | | | | | D5: 0 -> 16 Hz [63ms/8ch, 7.813ms/1ch] | 0 |
| NSCANSLP | | - | - | כען | - | - | - | - | - | D5: 1 -> 8 Hz [125ms/8ch, 15.625ms/1ch] | U |

 $[\]ensuremath{\mathbb{I}}$ When any key is touched, it goes to Burst mode.

7.7 I2C Device ID Setting

| INSTRUCTION |)NI | Command | | | | Para | meter | | | | Parameter Definition | Default |
|-------------|-----|---------|----|----|----|------|-------|----|----|----|---|----------|
| INSTRUCTION | JIN | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | | Deraun |
| I2CDEVICE | D | 06h | D7 | D6 | D5 | D4 | D3 | D2 | - | - | D[7:2] -> I2C_Device_ID Setting D[1:0] -> Default : 00, I2C_CS0 -> Low | 10111000 |

Default Slave Address : 54h

7.8 LED Control Mode

| | INSTRUCTION | Command | | | | Para | meter | r | | | Parameter Definition | Default |
|---|-------------|---------|----|----|----|------|-------|----|----|----|---|----------|
| l | INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | i dianicici Definition | Deraun |
| | LEDCTRL | 07h | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | D0 : 0 -> Port D[0] -> Low[0], D0 : 1 -> Port D[0] -> High[1] D1 : 0 -> Port D[1] -> Low[0], D1 : 1 -> Port D[1] -> High[1] D7 : 0 -> Port D[1] -> Low[0], D7 : 1 -> Port D[7] -> High[1] | 00000000 |

7.10 Channel Count Enable Time

| INSTRUCTION | Command | | | | Para | meter | | | | Parameter Definition | D-f14 |
|-------------|---------|----|----|----|------|-------|----|----|----------------|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | | Default |
| | | | | | | | | | | 0000 : 150 us Scan Count Enable Time : (D[3:0] +3) × 50us | |
| | | | | | | | | | | 0001 : 200 us | |
| | | | | | | | | | | 0010 : 250 us | |
| TICHCNT | 09h | | | | | D3 | D2 | D1 | D ₀ | | |
| TICHCNI | 0911 | - | - | - | - | נע | D2 | DI | 00 | 1001 : 600 us | О |
| | | | | | | | | | | | |
| | | | | | | | | | | 1110 : 850 us | |
| | | | | | | | | | | 1111 : 900 us | |

LDO Power Off Mode : Address[0x05]/Data[0x08] -> SYNC_INT Out State : Low (Register Address 0x02[ICPSEL] -> Data[0b111x xxxx])

7.11 Touch Duration Time

| INSTRUCTION | Command | | | | Para | meter | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|------|-------|----|----|---|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Farameter Definition | Deraun |
| | | | | | | | | | | 000 : More Than 0_Period of Burst Fast Mode | |
| | | | | | | | | | | 001 : More Than 1_Period of Burst Fast Mode | |
| | | | | | | | D2 | D1 | D0 | 010 : More Than 2_Period of Burst Fast Mode | О |
| TCHDR | 0Ah | - | - | - | - | - | D2 | DI | | | |
| Teribic | | | | | | | | | 110 : More Than 6_Period of Burst Fast Mode | | |
| | | | | | | | | | | 111 : More Than 7_Period of Burst Fast Mode | |
| | | - | - | D5 | D4 | - | - | - | - | 00 ~ 11 : Touch Output Delay | 01 |

7.12 Reference Update Guard (Threshold) Setting

| INSTRUCTION | Command | | | | Para | meter | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|------|-------|----|----|----|---|----------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Faranietei Demittion | Detaun |
| REFGUARD | 0Bh[11] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 00000000 ~ 11111111 : [Threshold] + [0 ~ 255] Count | 00100100 |

[■] Reference Guard Level: D[4:0]: 0~31 -> Threshold + REFGUARD[4:0]: Reference Update Stop Level

7.13 Global Touch Sensitivity (Threshold) Setting

| INSTRUCTION | Command | | | | Para | meter | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|------|-------|----|----|----|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Parameter Definition | Deraun |
| | | | | | | | | | | D[2:0] -> 000 : 0.0 % # of count deviation for 1st global threshold | |
| | | | | | | | | | | D[2:0] -> 001 : 0.4 % # of count deviation for 1st global threshold | |
| TYPE CY | 0Ch | - | - | - | - | - | D2 | D1 | D0 | D[2:0] -> 010 : 0.8 % # of count deviation for 1st global threshold | О |
| THRGL | [12] | | | | | | | | | D[2:0] -> 011 : 1.5 % # of count deviation for 1st global threshold | |
| | | | | | | | | | | D[2:0] -> 100 : 3.1 % # of count deviation for 1st global threshold | |
| | | D7 | D6 | D5 | D4 | D3 | - | | - | D[7:3] -> 000000 ~ 111111 : D[2:0]% + Global Count [0 ~ 31] Count | 00000 |

I Global touch sensitivity level setting.

7.14 Local Touch Sensitivity (Threshold) Setting

| INSTRUCTION | Command | | | | Para | metei | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|------|-------|----|----|----|---|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Parameter Definition | Deraun |
| THRLC0 | 0Dh[13] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC1 | 0Eh[14] | - | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC2 | 0Fh[15] | - | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC3 | 10h[16] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC4 | 11h[17] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC5 | 12h[18] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC6 | 13h[19] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |
| THRLC7 | 14h[20] | ı | D6 | D5 | D4 | D3 | D2 | D1 | D0 | 0000000 ~ 1111111 : [THRGL] + [0 ~ 127] Count | 0000010 |

 $[\]ensuremath{\mathbb{I}}$ Local touch sensitivity level setting for each key.

Parameter definition

| D[5:0] | comments |
|---------|--------------------------------|
| 0000000 | 0 counts for local threshold |
| 0000001 | 1 counts for local threshold |
| 0000010 | 2 counts for local threshold |
| | |
| 0001000 | 8 counts for local threshold |
| | |
| 1111110 | 126 counts for local threshold |
| 1111111 | 127 counts for local threshold |

Chatter Prevent Level: D[7:4]: 0~31 -> Touch On -> Threshold + REFGUARD[7:4] + 3 -> Threshold level up

It controls the sensitivity of all keys simultaneously by digital algorithm.

It controls the sensitivity of each key individually by changing the threshold.

¹² parameters must follow command '0Ch consecutively. It overwrite the parameters from 1st channel to 12th channel.

7.15 Reference Count Generation for Touch On Process

| INSTRUCTION | Command | | | | Para | mete | r | | | Parameter Definition | Default |
|-------------|-------------|-----|----|----|------|------|----|----|----|---|-----------------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | raidiliètei Definition | Derault |
| REFGENON | 1Ah [26] | - 1 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | D[6:0] -> 0000000(0) ~ 1111111(127) : Reference On Count Period | 1000000 (64) |

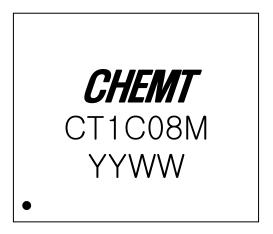
7.16 Concurrent Touch Handling

| INSTRUCTION | Command | | | | Parai | metei | | | | Parameter Definition | Default |
|-------------|---------|----|----|----|-------|-------|----|----|----|-------------------------|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Farameter Definition | Detaun |
| CONCTCH | 23h | - | - | - | - | - | - | D1 | D0 | 00: First touched | |
| CONCICH | [35] | - | - | - | , | - | | D1 | D0 | 11 : Basic(all) touched | О |

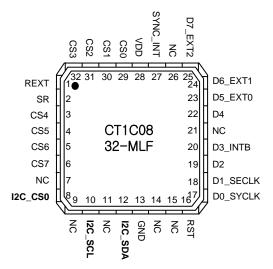
7.17 Read Only Register

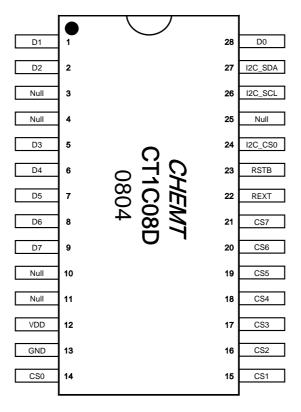
| INSTRUCTION | Command | | | | Para | mete | r | | | Parameter Definition | Default |
|-------------|----------|----|----|----|------|------|----|----|----|--|---------|
| INSTRUCTION | A[7:0] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Faranietei Dennition | Deraun |
| REG_2Ah | 2Ah [42] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | D[7:0]: Touch Output Data[7:0] | Read |
| REG_2Bh | 2Bh [43] | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | D[7:0] : Scan Count Data Low Byte[7:0] | Read |
| REG_2Ch | 2Ch [44] | - | - | - | - | D3 | D2 | D1 | D0 | D[3:0] : Scan Count Data High Byte[11:8] | Read |

8. CHIP MARKING



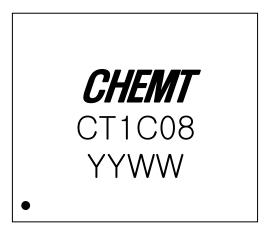
9. PACKAGE PIN CONFIGURATION



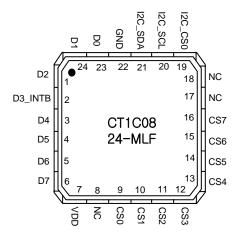


Package Type: SO28P[300mil]

CHIP MARKING



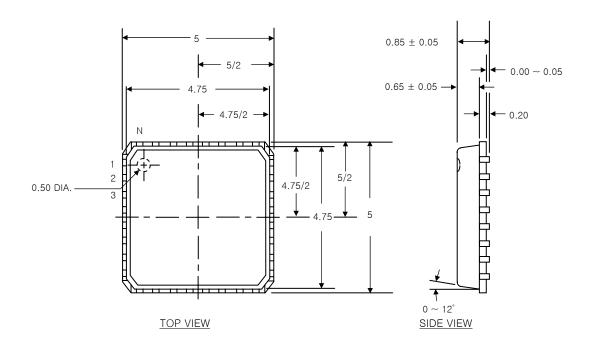
PACKAGE PIN CONFIGURATION

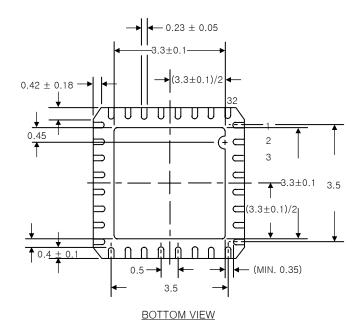


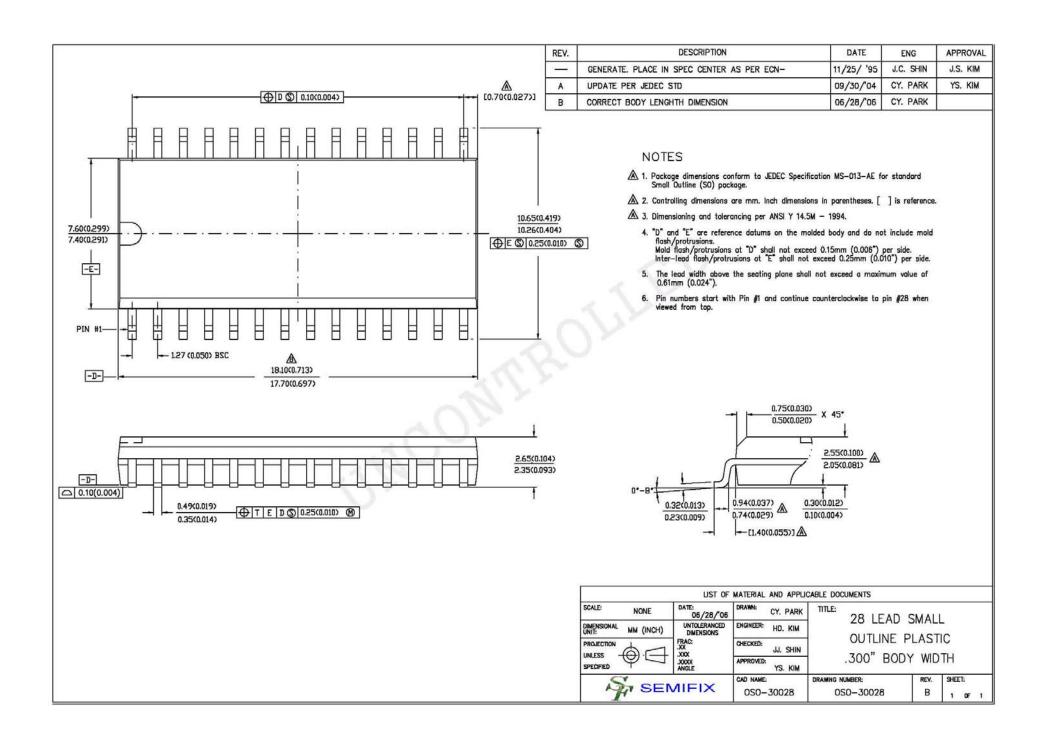
Package Type: MLF2-24[4×4]

PACKAGE INFORMATION

Package Type: MLF2-32[5×5]

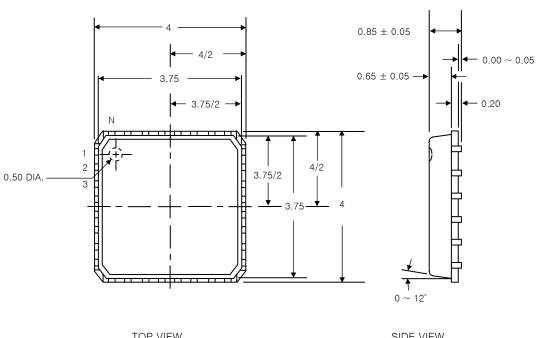




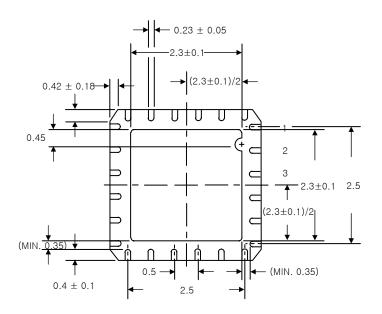


PACKAGE INFORMATION

Package Type: MLF2-24[4×4]



TOP VIEW SIDE VIEW



BOTTOM VIEW